

# iPEM, ASYNC SRAM

## 16Mb, 512K x 32

Part Numbers: AS8S512K32PECB



## Preliminary Data Sheet

The Microcross Integrated Asynchronous Static Random Access memory component is manufactured utilizing (4) 4Mb, Asynchronous SRAMs integrated on an organic substrate with Lead-frame and encapsulated. The device is a High Speed, Power efficient random access memory device supporting parallel Byte, Word and Double Word accesses via use of multiple chip enables and is packaged in a manufacturing friendly surface mount PLCC footprint.

The Microcross 16Mb SRAM iPEM operates from a single 5V supply, is TTL and CMOS compatible and is a fully static device requiring no clocks or memory cell refreshes to operate.

## Features

### General:

- Access Time: 12,15, 20 & 25ns
- Low Active Power: 1.55 watts (Typical)
- Low CMOS Standby Power: 400mW (Typical)
- Single 5V supply
- TTL compatible interface

### Density and Organization:

- 16Mb, 512K x 32

### Package:

- 68 Lead PLCC
- JEDEC MS-018, AE

### Operating Voltage Range:

- VCC: 4.50V – 5.50V

### Operating Temperature Range:

- -55°C to +125°C

## Revision History

Revision	Description	Release Date
0.0	Initial Release, 16Mb, x32, Integrated Plastic Encapsulated, Asynchronous SRAM, packaged in PLCC, 68LD, MO-047AE	September, 2005
0.1	Updated Ordering information	January, 2009
0.2	Added Micross information	January 2010
0.3	Upgraded Document to "RELEASE" status, obsoleted PEC package due to pin-out errors, added PECA package with revised pin-out.	March 2011
1.0	68-PLCC Package mechanical revised, conforming to MS-018AE, New Micross Datasheet format and revision to ICC1, ICC2 and ICC3 and TELQX specification limit change	6/16/2021

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## 1.0 Preface

This Product document uses typographical conventions to assist the reader in understanding the content. This section will define the test formatting used in the rest of the document.

### 1.1 Text Usage

**BOLD** – indicates important information and table, figure, and chapter references.

***BOLD ITALIC*** – designates Micross part number

< ..... > - indicates user-entered text or comments

### 1.2 Standard Definitions

<b>ASYNC</b>	Asynchronous
<b>SRAM</b>	Static Random Access Memory
<b>V</b>	Voltage
<b>mA</b>	milliamp
<b>μA</b>	microamp
<b>ns</b>	nanosecond
<b>pF</b>	picofarad
<b>A</b>	Address Bus
<b>Ex\</b>	Chip Enable, Active Low, Byte 0, 1, 2 & 3
<b>W\</b>	Write Enable, Active Low
<b>G\</b>	Output Enable, Active Low
<b>DQ</b>	Data Bus, input and output
<b>/IT</b>	Industrial temperature range
<b>/ET</b>	Extended temperature range
<b>/XT</b>	Military temperature range

### 1.3 Technical Support

In the event you have questions and/or need for information beyond the scope of this document, you may contact Micross Components via the following methods:

Micross Website: <https://www.micross.com/contact-us/sales-contacts/>

## 2.0 Functional Description

The Micross AS8S512K32PECB is a high speed, 5V 16Mb multi-chip, integrated plastic encapsulated Asynchronous SRAM Microcircuit, supplied in the Industries PLCC, a J-leaded surface mount component. The device is available with access times of 12, 15, 20 and 25ns, creating a zero wait-state/latency, real-time memory solution. The high speed, 5V supply voltage and flexible control interface make the device ideal for all your real-time embedded computer memory requirements.

The device can be configured as a 512K x 32 with individual byte controls via use of E0\E3\ or reconfigured as a 1M x 16 or 2M x 8 via use of the same Chip Enables in addition to the Write Enable (W\ ) and Output Enable (G\ ) controls.

The device provides a 50+ percent space savings when compared with four 512K x 8, 36 pin SOJ devices. In addition, the AS8S512K32 has only a 20pF capacitance load on the Address lines vs. approximately 30pF for the four 36LD SOJs.

## 3.0 Packages

Table 1. Packages		
Package Type	Lead Count	Part Number
Plastic J-Lead	68	PECB

## 4.0 Applicable Quality Flows

Table 2. Applicable Quality Levels			
Micross Plastic iPEM Flow		Part Number	Temp Range
Options:	INDUSTRIAL	IT	-40°C - +85°C
	ENHANCED	ET	-40°C - +105°C
	MIL-TEMP	XT	-55°C - +125°C

## 5.0 Functional Block Diagram

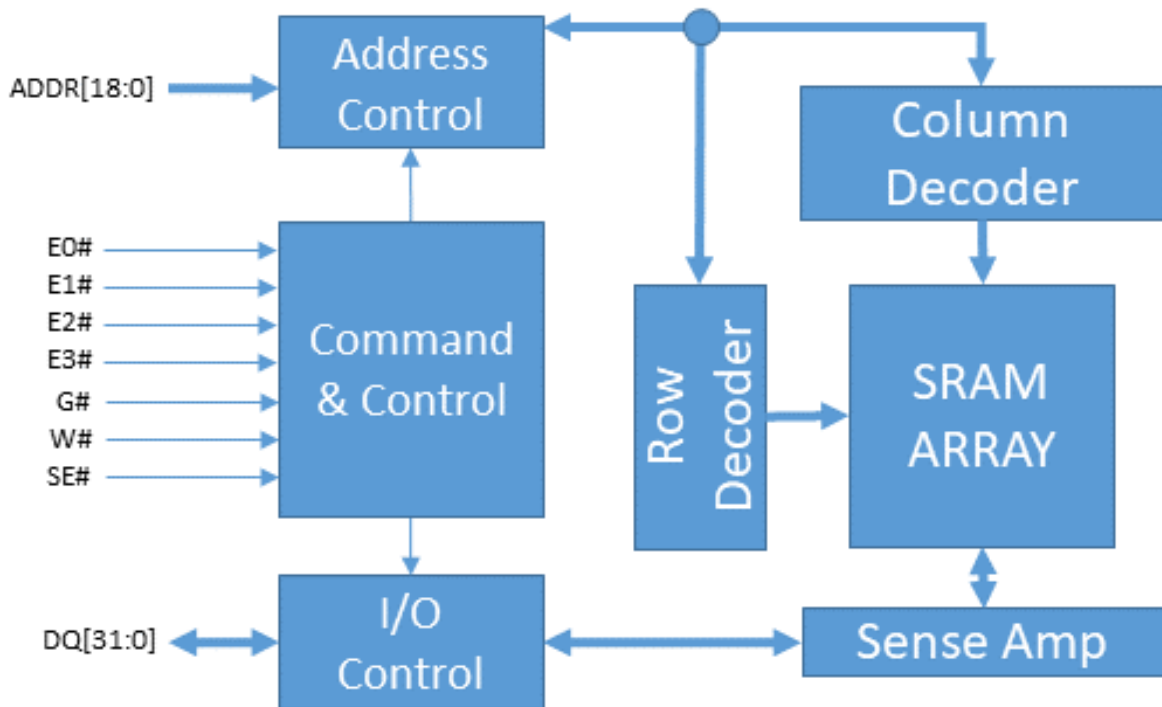


Figure 1. Functional Block Diagram



## 6.0 Performance Characteristics

Table 3. Performance Characteristics	
Parameter	Value
READ/WRITE MIN ACCESS TIMES	12ns
MAX OPERATING CURRENT	310mA
TTL STANDBY CURRENT	120mA
CMOS STANDBY CURRENT	80mA

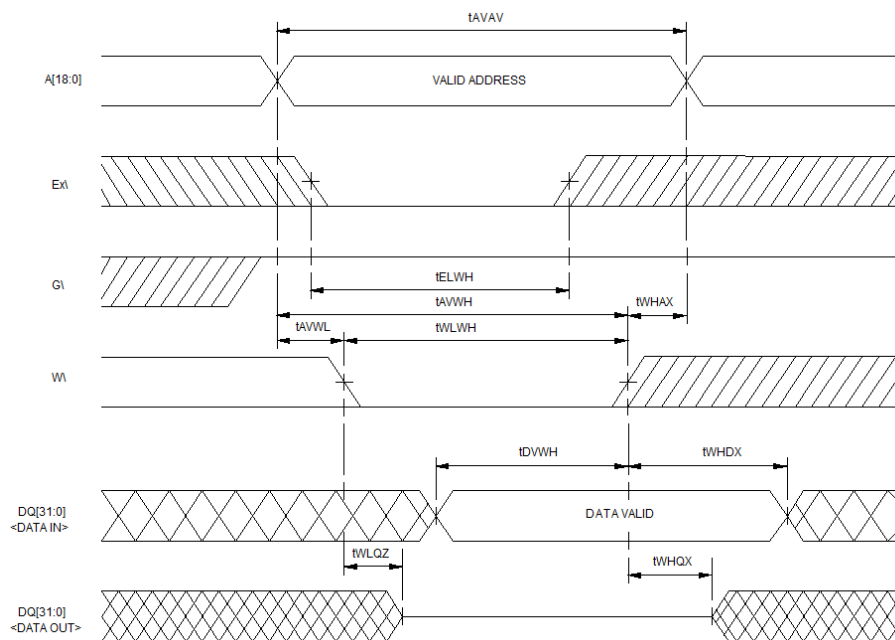
## 7.0 Signal Descriptions

Table 4. Signal Descriptions		
Signal	Type	Description
E0\,E1\,E2\ & E3\	INPUT	Chip Enables, one per byte
W\	INPUT	Chip Enable
G\	INPUT	Output Enable
A[18:0]	INPUT	Addressable locations: 512K, 19 addresses
DQ[31:0]	I/O	Data Bus: 32 bit
VCC	SUPPLY	Core and I/O Positive Power supply
VSS	SUPPLY	Core and I/O Ground supply
NC		No Connects

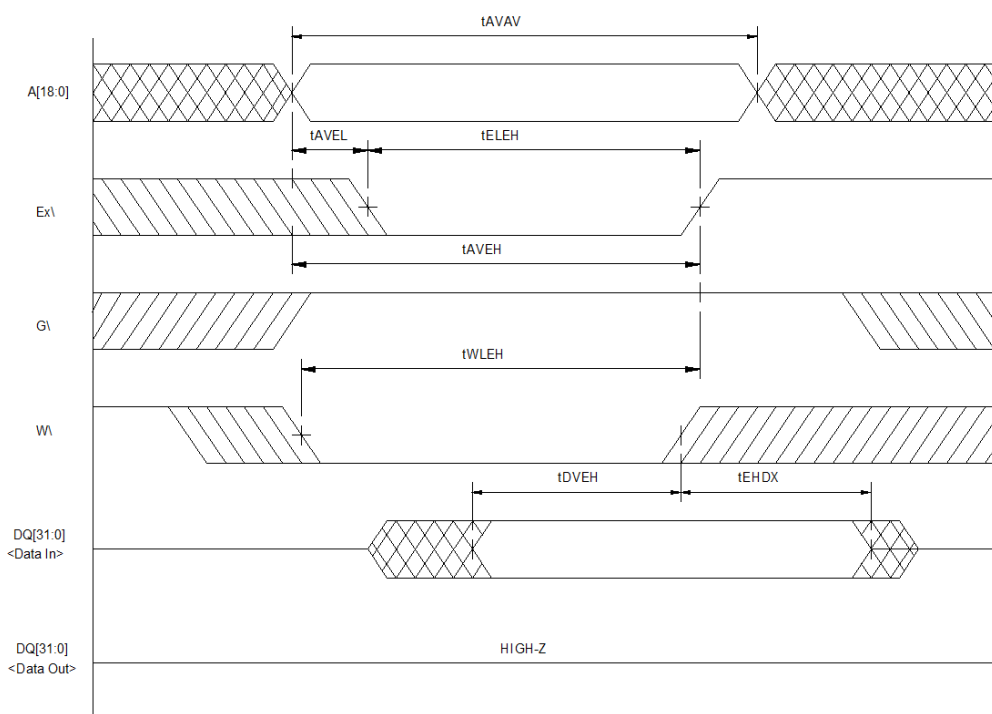
## 8.0 Modes of Operation

Table 5. Mode of Operation								
Mode	E0\	E1\	E2\	E3\	G#	W#	DQ[31:0]	Current
Not Selected	H	H	H	H	X	X	HI-Z	I <sub>SB</sub>
Output Disabled	L	L	L	L	H	H	HI-Z	I <sub>CC2</sub>
READ BYTE 0	L	H	H	H	L	H	Data-Out	I <sub>CC1</sub>
READ BYTE 1	H	L	H	H	L	H	Data-Out	I <sub>CC1</sub>
READ BYTE 2	H	H	L	H	L	H	Data-Out	I <sub>CC1</sub>
READ BYTE 3	H	H	H	L	L	H	Data-Out	I <sub>CC1</sub>
READ WORD 0	L	L	H	H	L	H	Data-Out	I <sub>CC1</sub>
READ WORD 1	H	H	L	L	L	H	Data-Out	I <sub>CC1</sub>
READ DOUBLE WORD	L	L	L	L	L	H	Data-Out	I <sub>CC1</sub>
WRITE BYTE 0	L	H	H	H	H	L	Data-In	I <sub>CC1</sub>
WRITE BYTE 1	H	L	H	H	H	L	Data-In	I <sub>CC1</sub>
WRITE BYTE 2	H	H	L	H	H	L	Data-In	I <sub>CC1</sub>
WRITE BYTE 3	H	H	H	L	H	L	Data-In	I <sub>CC1</sub>
WRITE WORD 0	L	L	H	H	H	L	Data-In	I <sub>CC1</sub>
WRITE WORD 1	H	H	L	L	H	L	Data-In	I <sub>CC1</sub>
WRITE DOUBLE WORD	L	L	L	L	H	L	Data-In	I <sub>CC1</sub>

## 8.1 WRITE Operation



**Figure 2. Write Operation ( $W\#$  Controlled)**

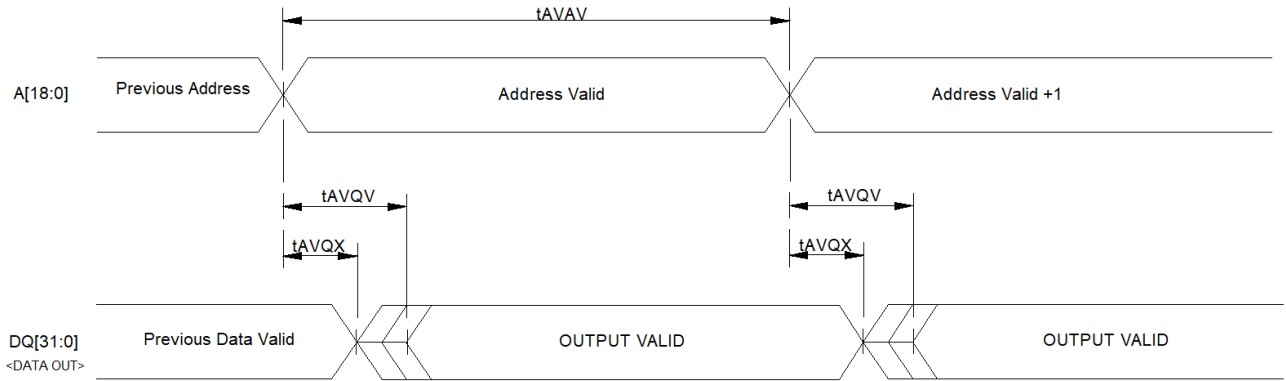


**Figure 3. Write Operation ( $E\#$  Controlled)**

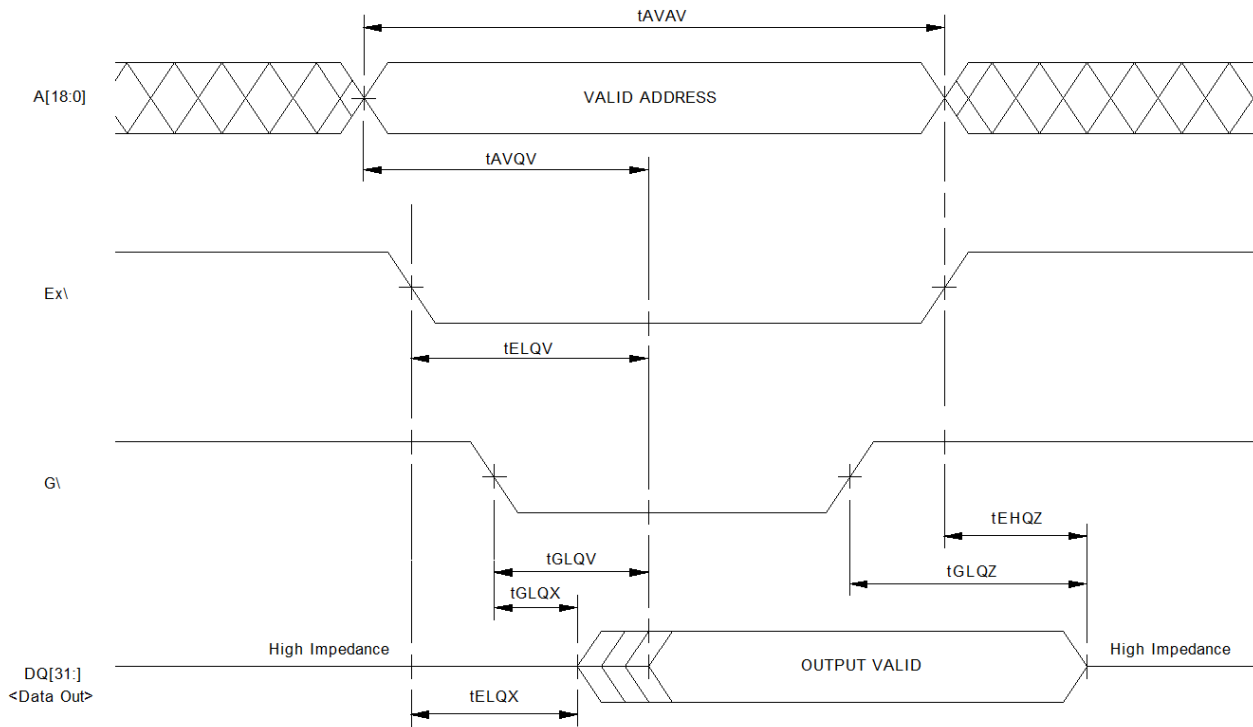
Table 6. WRITE Operation Timing

Parameter	Symbol	12ns		15ns		205ns		25ns		Units
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
WRITE Cycle Time	tAVAV	12	-	15	-	20	-	25	-	ns
Chip Enable to End of Write	tELWH	8	-	10	-	11	-	12	-	ns
	tELEH	8	-	10	-	11	-	12	-	
Address Setup Time	tAVWL	0	-	0	-	0	-	0	-	ns
	tAVEL	0	-	0	-	0	-	0	-	
Address Valid to End of Write	tAVWH	8	-	10	-	11	-	12	-	ns
	tAVEH	8	-	10	-	11	-	12	-	
Write Pulse Width	tWLWH	8	-	10	-	11	-	12	-	ns
	tELEH	10	-	12	-	13	-	14	-	
Write Recovery Time	tWHAX	0	-	0	-	0	-	0	-	ns
	tEHAX	0	-	0	-	0	-	0	-	
Data Hold Time	tWHDX	0	-	0	-	0	-	0	-	ns
	tEHDX	0	-	0	-	0	-	0	-	
Write to Output in High Z	tWLQZ	0	6	0	7	0	8	0	9	ns
Data to Write Time	tDVWH	6	-	7	-	8	-	9	-	ns
	tDVEH	6	-	7	-	8	-	9	-	
Output Active from End of Write	tWHQX	3	-	3	-	3	-	3	-	ns

## 8.2 READ Operation



**Figure 4. Continuous READ Operation**



**Figure 5. READ Operation, G\ Controlled**

Table 7. READ Operation Timing										
Parameter	Symbol	12ns		15ns		20ns		25ns		Units
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
READ Cycle Time	tAVAV	12	-	15	-	20	-	25	-	ns
Address Cycle Time	tAVQV	-	12	-	15	-	20	-	25	ns
Chip Enable Access Time	tELQV	-	12	-	15	-	20	-	25	ns
Chip Enable to Output in Low Z	tELQX	2	-	2	-	2	-	2	-	ns
Chip Disable to Output in High Z	tEHQZ	-	6	-	6	-	6	-	6	ns
Output Hold from Address Change	tAVQX	3	-	3	-	3	-	3	-	ns
Output Enable to Output Valid	tGLQV	-	6	-	6	-	6	-	6	ns
Output Enable to Output Low Z	tGLQX	0	-	0	-	0	-	0	-	ns
Output Enable to Output High Z	tGHQZ	-	6	-	6	-	6	-	6	ns

## 9.0 Signal Pad Location

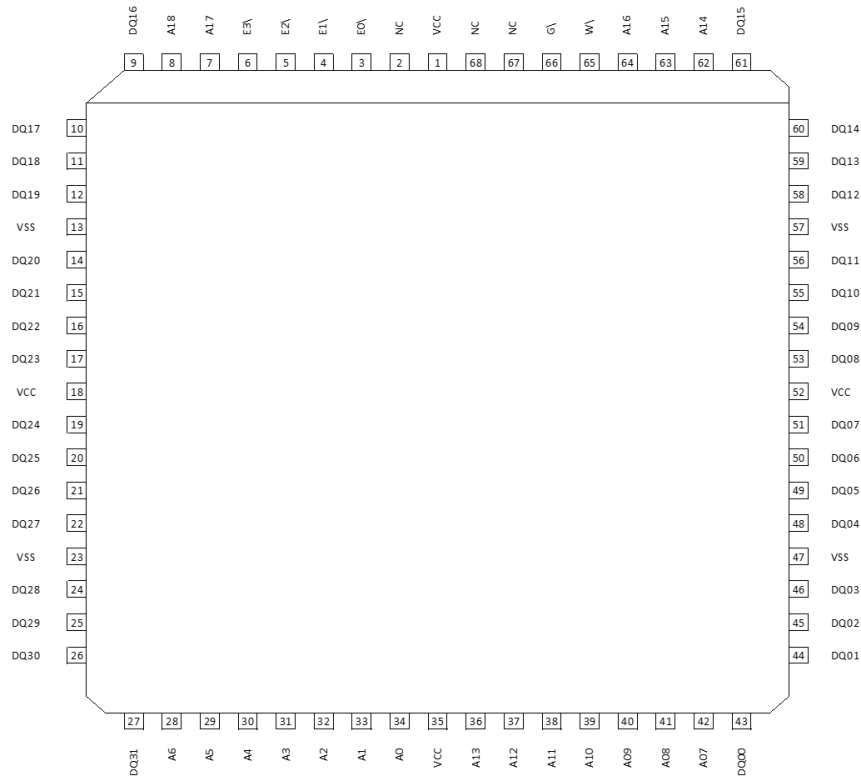


Figure 6. PLCC 68 Lead Signal Pad Location

Table 8. Package Size				
Package	Package Type	Pin Count	Length	Width
PLCC	PECB	68	0.990 INCH	0.990 INCH

Note: Package Outline Drawings on Page 17

## 10.0 Electrical Characteristics

Table 9. Absolute Maximum Ratings	
Voltage on any Pin relative to $V_{SS}$	-0.5V to 7.0V
Operating Temperature, $t_A$ (Ambient)	Industrial
	Enhanced
	Mil-Temp
Storage Temperature	-55°C to +125°C
Power Dissipation	5.0 Watts
Output Current	20mA
Junction Temperature, $T_J$	175°C

Table 10. Recommended Operating Conditions						
Parameter	Parameter/Test Conditions	Symbol	MIN.	TYP.	MAX.	Units
SUPPLY VOLTAGE	5.0V Normal	$V_{CC}$	4.5	5	5.5	V
SUPPLY VOLTAGE	Digital GND	$V_{SS}$	0	0	0	V
INPUT HIGH VOLTAGE	INPUT LOGIC HIGH	$V_{IH}$	2.2	--	$V_{CC} + 0.5V$	V
INPUT LOW VOLTAGE	INPUT LOGIC LOW	$V_{IL}$	-0.3	--	0.8	V

Table 11. Capacitance						
Parameter	Parameter/Test Conditions	Symbol	MIN.	TYP.	MAX.	Units
Input Pin	TEMP = 25°C; f = 1MHz; $V_{IN} = 0V$	$C_{IN}$	-	-	20	pF
Input/Output	TEMP = 25°C; f = 1MHz; $V_{IN} = 0V$	$C_{IO}$	-	-	7	pF
W\, G\	TEMP = 25°C; f = 1MHz; $V_{IN} = 0V$	CW, CG			20	pF
E0\,E1\,E2\ & E3\	TEMP = 25°C; f = 1MHz; $V_{IN} = 0V$	CE			7	pF

Table 12. DC Characteristics

Parameter	Parameter/Test Conditions	Symbol	MIN.	TYP.	MAX.	Units
Operating Current	VCC (max), I <sub>OUT</sub> = 0 ma	I <sub>CC1</sub>	-	-	310	mA
STANDBY Current	E# = V <sub>IH</sub> , VCC (max)	I <sub>CC2</sub>	-	-	120	mA
Full STANDBY Current	VCC (max), 125°C	I <sub>CC3</sub>	-	-	80	mA
Input Leakage Current	V <sub>IN</sub> = 0 to VCC (max)	I <sub>LI</sub>	-5.0	-	5.0	μA
Output Leakage Current	V <sub>OUT</sub> = 0 to VCC (max)	I <sub>LO</sub>	-5.0	-	5.0	μA
Output HIGH Voltage	I <sub>OH</sub> = -1.6mA	V <sub>OH</sub>	2.4	-	-	V
Output LOW Voltage	I <sub>OL</sub> = 1.6mA	V <sub>OL</sub>	-	-	0.4	V

Table 13. AC Test Conditions

Parameter	Value
Input pulse levels	V <sub>SS</sub> to 3.0V
Input rise and fall times	5ns
Input and Output timing levels	1.5V
Output load	FIGURE 11
Output load (t <sub>EHQZ</sub> , t <sub>GHQZ</sub> and t <sub>WLQZ</sub> )	FIGURE 12

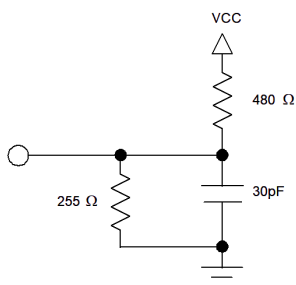


Figure 7. Output Load

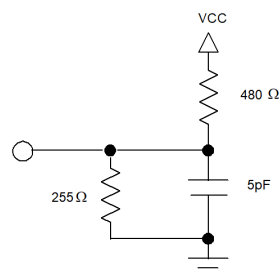


Figure 8. Output Load, High-Z



## 11.0 Package Outline Drawings

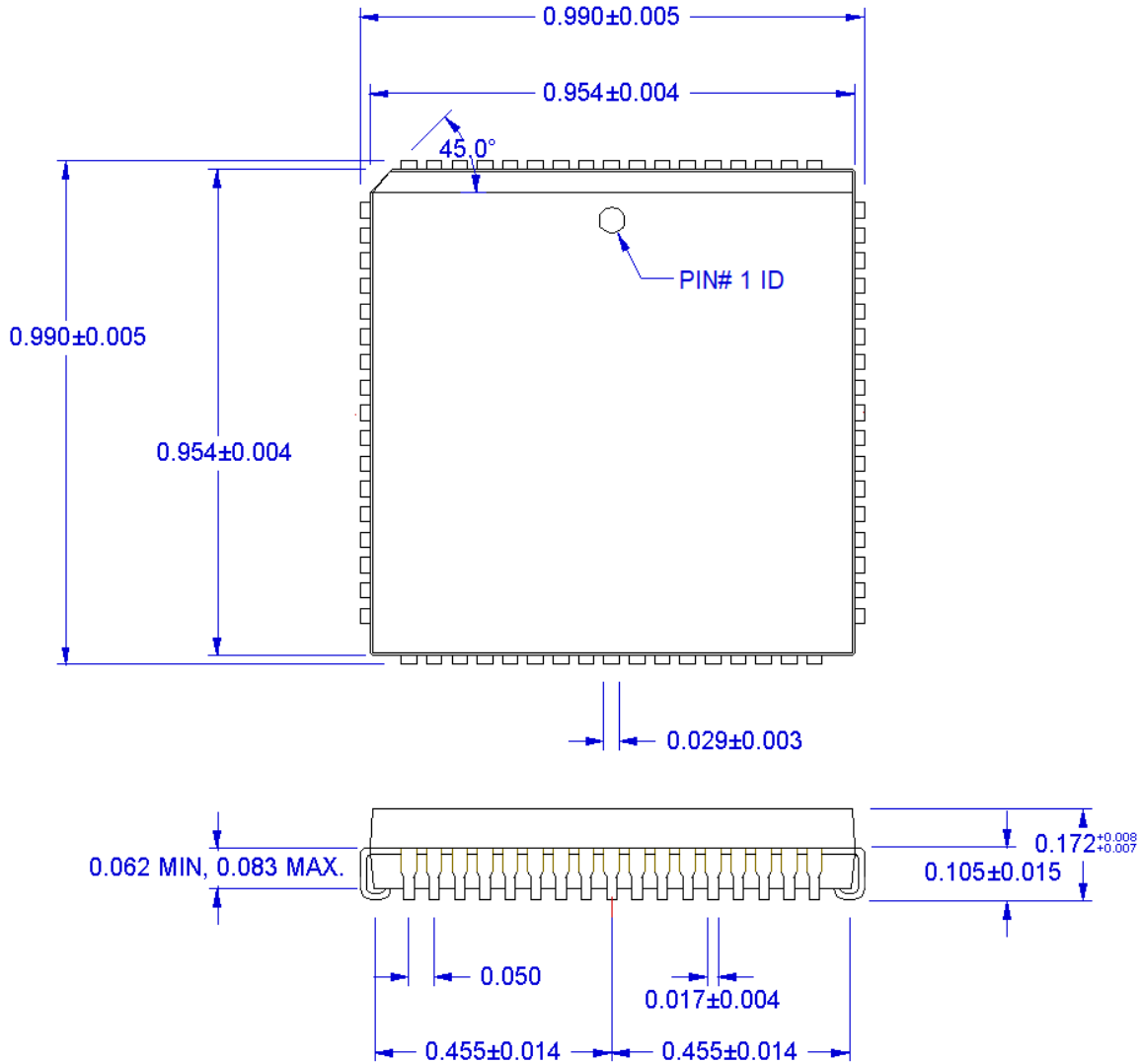


Figure 9. Plastic PLCC, 68 Lead, MS-018[AE]

## 12.0 Ordering Information

**Table 14. Ordering Information**

Part Number	Description	Package	Quality Level
AS8S512K32PECA-12/IT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 12ns	68-PLCC	Industrial
AS8S512K32PECA-15/IT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 15ns	68-PLCC	Industrial
AS8S512K32PECA-20/IT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 20ns	68-PLCC	Industrial
AS8S512K32PECA-25/IT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 25ns	68-PLCC	Industrial
AS8S512K32PECA-12/ET	16Mb iPEM, 5V, 512K x 32, Async SRAM, 12ns	68-PLCC	Enhanced
AS8S512K32PECA-15/ET	16Mb iPEM, 5V, 512K x 32, Async SRAM, 15ns	68-PLCC	Enhanced
AS8S512K32PECA-20/ET	16Mb iPEM, 5V, 512K x 32, Async SRAM, 20ns	68-PLCC	Enhanced
AS8S512K32PECA-25/ET	16Mb iPEM, 5V, 512K x 32, Async SRAM, 25ns	68-PLCC	Enhanced
AS8S512K32PECA-12/XT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 12ns	68-PLCC	Mil-Temp
AS8S512K32PECA-15/XT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 15ns	68-PLCC	Mil-Temp
AS8S512K32PECA-20/XT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 20ns	68-PLCC	Mil-Temp
AS8S512K32PECA-25/XT	16Mb iPEM, 5V, 512K x 32, Async SRAM, 25ns	68-PLCC	Mil-Temp



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